

Low-Loss Superconducting Nanowire Circuits Using a Neon Focused Ion Beam

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We present low-temperature measurements of low-loss superconducting nanowire-embedded resonators in the low-power limit relevant for quantum circuits. The superconducting resonators are embedded with superconducting nanowires with widths down to 20 nm using a neon focused ion beam. In the low-power limit, we demonstrate an internal quality factor up to 3.9×10^5 at 300 mK [implying a two-level-system-limited quality factor up to 2×10^5 at 10 mK], not only significantly higher than in similar devices but also matching the state of the art of conventional Josephson-junction-embedded resonators. We also show a high sensitivity of the nanowire to stray infrared photons, which is controllable by suitable precautions to minimize stray photons in the sample environment. Our results suggest that there are excellent prospects for superconducting-nanowire-based quantum circuits.

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I. INTRODUCTION

Quantum circuits based on conventional Josephson junctions have begun to tackle real-world problems [1]. This has been despite high decoherence produced by the loss [2,3] and noise [4,5] caused by parasitic two-level systems (TLSs) [6,7]. In principle, superconducting nanowires can provide a route to low-decoherence quantum circuits due to their monolithic structure and lack of a TLS-hosting oxide layer. To date, superconducting nanowires with cross-sectional areas approaching the coherence length have demonstrated a variety of Josephson [8,9] and phase-slip [10–13] effects, but features such as their unconventional current-phase relationships [14] remain unexploited in quantum circuits. Previous demonstrations of superconducting nanowire-embedded resonators exhibit unusually high dissipation, with internal quality factors (Q_i) below 5×10^3 [10–12,15], far lower than in similar conventional Josephson-junction-based circuits [16,17]. In general, the performance of nanowire-embedded resonators can be limited by material quality, interface imperfections, resist residues, and the measurement environment.

We demonstrate superconducting nanowire-embedded circuits with single photon Q_i up to 3.9×10^5 , comparable to or even better than conventional Josephson-junction resonators. Superconducting nanowires with widths down to 20 nm are fabricated with a neon focused ion beam (FIB). We study the loss in our devices within the well-established

framework of loss mechanisms in superconducting resonators [2,3,7,18,19] to determine which factors are significant in limiting their performance. The vastly improved Q_i demonstrates that the detrimental effects can be sufficiently reduced and shows that competitive quantum circuits can be based on monolithic nanowire technology.

II. METHODS

Superconducting 20-nm-thick NbN films are deposited on sapphire by dc magnetron sputtering from a 99.99%-pure Nb target in a 1:1 Ar:N₂ atmosphere. The vacuum chamber is pumped to 6×10^{-7} mbar before sputtering at a pressure of 3.5×10^{-3} mbar and power of 200 W. The superconducting critical temperature T_c is 10 K, with a sheet resistance of 450 Ω/sq . Electron-beam lithography (EBL) is used to pattern $\lambda/4$ and $\lambda/2$ coplanar microwave resonators capacitively coupled to a common microwave feed line [shown in Fig. 1(d)]. The width of the central conductor is 10 μm , and the gap is 5 μm . This pattern is transferred from a 300-nm-thick layer of polymethyl methacrylate into the film by a reactive ion etch using a 2:1 ratio of SF₆:Ar at 30 W and 30 mbar.

A neon FIB is used to directly pattern [20] nanowires in the central conductor of the microwave resonators at the current antinode; see Fig. 1(b). With an acceleration voltage of 15 kV, the clearance dose for the NbN film is approximately 0.3 nC/ μm^2 . We choose 15 kV as a compromise between minimizing the spot size and minimizing the lateral milling of the nanowire [21], leading to a few-minute mill time per μm^2 for an approximately 1-pA beam current. By prior patterning of a sub-200-nm-wide precursor wire in the same EBL step as the resonator [shown in Fig. 1(c)], we minimize the mill time and the total neon flux that the nanowire is subject to. Several devices are measured, and Table I shows important parameters

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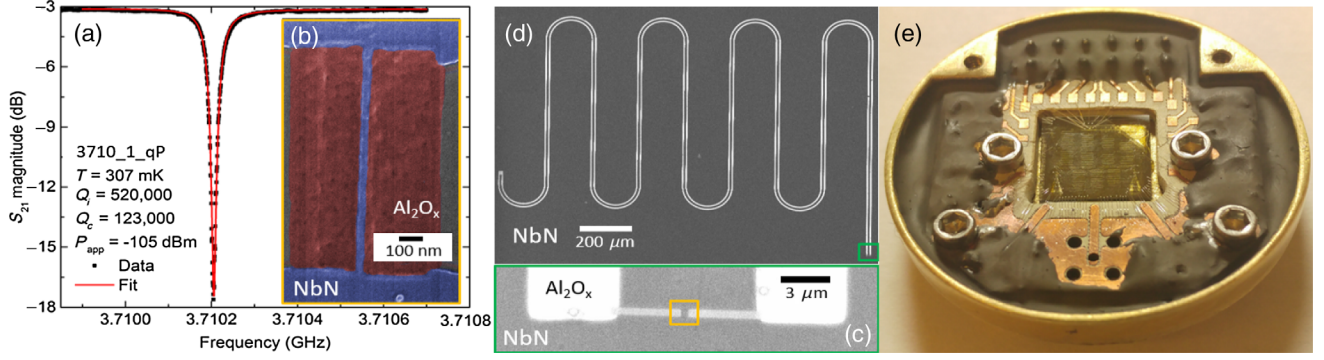


FIG. 1. (a) The S_{21} magnitude response of the nanowire-embedded resonator 3710_1qP. The red line is a fit to Eq. (1). (b) A false-color He FIB micrograph of a neon FIB-milled nanowire (3710_1qP) with dimensions of 27 nm by 1.2 μm . The NbN is shown in blue, while the milled region is shown in red. (c),(d) Scanning electron micrographs of (c) the shorted end of a $\lambda/4$ resonator before milling by neon FIB. (d) The whole $\lambda/4$ resonator. (e) A photograph of the sample holder. In the center is a chip, which is wire bonded to a microwave printed circuit board; the dark material is ECCOSORB CR 117.

including the nanowire dimensions. The nanowire devices all feature two nanowires configured either in parallel so that the nanowires complete a superconducting loop [12] or in series with a wider segment in between [22]. Here, there is no external flux bias or external gate bias, so the nanowires are treated as simple constrictions within the superconductor.

The samples are enclosed within a brass box and cooled using a ^3He refrigerator containing a heavily attenuated microwave in line and out line with a cryogenic high-electron-mobility-transistor amplifier.

III. RESULTS AND DISCUSSION

Figure 1(a) shows the forward transmission (S_{21}) magnitude response of a nanowire-embedded resonator at 307 mK and for an applied microwave drive of -105 dBm, demonstrating $Q_i = 5.2 \times 10^5$. This Q_i is significantly higher than in comparable nanowire-based devices [10–12,15]. This highlights the promise of the neon FIB and demonstrates that superconducting nanowires are not intrinsically lossy. The complex S_{21} notch response of the superconducting resonators is fitted by [23]

$$S_{21}(\nu) = ae^{j\theta}e^{-2\pi j\nu\tau} \left[1 - \frac{(Q_L/|Q_c|)e^{j\phi}}{1 + 2jQ_L(\nu/\nu_0 - 1)} \right], \quad (1)$$

where ν is the applied frequency, ν_0 the resonance frequency, Q_L the loaded quality factor, and $|Q_c|$ the absolute value of the coupling quality factor. ϕ accounts for impedance mismatches, a describes a change in amplitude, θ describes a change in phase, and τ a change in the electronic delay. The internal quality factor Q_i is defined by $1/Q_L = 1/Q_i + \text{Re}(1/Q_c)$, and the energy within the resonator is $W_{\text{sto}} = 2P_{\text{app}}S_{\text{min}}Q_L/\omega_0$, where P_{app} is the applied microwave power (in watts), and S_{min} the normalized minimum of the resonator magnitude response. We describe the microwave power in terms of the average number of photons in the resonator $\langle n \rangle$ given by $\langle n \rangle = W_{\text{sto}}/(h\nu_0)$, where h is Planck's constant.

To examine the effect of the neon FIB on the NbN film, we measure the resonator response as a function of the temperature (shown in Fig. 2). As the temperature decreases from 2 to 1 K, the resonant frequency increases due to changes in the complex conductivity, which are described by $(\Delta\nu/\nu_0) = (\alpha/2)(\Delta\sigma_2/\sigma_2)$, where $(\Delta\nu/\nu_0)$ is

TABLE I. Table of resonator parameters. Resonators are named by ν_0 (MHz), their chip number $\lambda/4$ (q) or $\lambda/2$ (h), and whether they are bare resonators (B), have nanowires in series (S), have nanowires in parallel (P), or are measured in an ECCOSORB-lined box (E). \bar{w} refers to the nanowire widths. δ_{TLS}^i comes from fits to Eq. (2), while δ_{TLS}^0 and δ_{QP} come from fits to Eq. (3), and $FP_{\gamma\chi}$ come from fits to Eq. (4).

Resonator	\bar{w} (nm)	$F\delta_{\text{TLS}}^i (\times 10^{-6})$	$FP_{\gamma\chi} (\times 10^{-6})$	$F\delta_{\text{TLS}}^0 (\times 10^{-6})$	$\delta_{\text{QP}} (\times 10^{-7})$
4094_1qB	...	6	0.57	6.6	5.6
3995_1hB	...	6.3	0.61	6.2	6.9
3675_2qBE	...	9.8	1.11	9.5	5.6
2739_2hBE	...	12.6	1.21	10.2	13.3
3710_1qP	27, 30	4.8	0.47	5.9	12.4
3012_1hS	47, 48	6.9	0.42	7.8	21.1
3382_2qPE	20, 23	12.9	1.13	14.3	5.4
3468_2hSE	37, 34	13.0	1.27	14.2	6.8

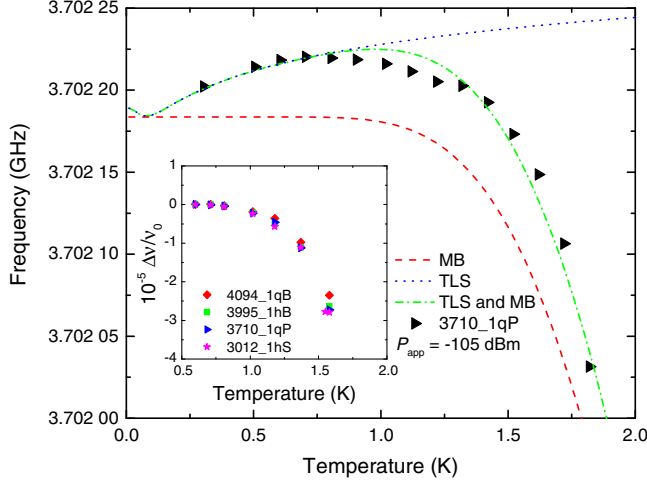


FIG. 2. Resonant frequency of resonator 3710_1_qP as a function of the temperature. Red broken line: Variation arising from kinetic inductance changes described by MB theory. Blue dotted line: Variation arising from TLS losses. Green dash-dotted line: Fit to data including both MB and TLS effects. Inset: Normalized frequency shift as a function of the temperature for all resonators on chip 1.

the normalized change in resonance frequency, α is the kinetic inductance fraction, and σ_2 is the imaginary part of the complex conductivity as given by Mattis-Bardeen (MB) theory [24]. The inset of Fig. 2 shows the temperature dependence of the resonant frequency for all resonators on chip 1. The bunching of data points indicates a very similar T_c whether the resonator contains nanowires or not, implying that the neon FIB has not significantly suppressed the superconductivity.

Further decreasing the temperature from 1 K, the resonant frequency decreases due to a thermal desaturation of TLSs, which can be described by

$$\frac{\nu_0(T) - \nu_0(T_0)}{\nu_0(T_0)} = F\delta_{\text{TLS}}^i \left\{ \ln\left(\frac{T}{T_0}\right) - [g(T, \omega) - g(T_0, \omega)] \right\}, \quad (2)$$

where $g(T, \omega) = \text{Re}\Psi\left(\frac{1}{2} + \frac{\hbar\omega}{2\pi j k_B T}\right)$, F is the filling factor which typically relates to device geometry and electric field density, T_0 is a reference temperature, Ψ is the complex digamma function, and $F\delta_{\text{TLS}}^i$ is the intrinsic loss tangent. Figure 2 shows a fit to both the MB and TLS frequency shifts, and the extracted $F\delta_{\text{TLS}}^i$ is shown in Table I. Barends *et al.* [25] have previously showed that to determine $F\delta_{\text{TLS}}^i$ using both MB and TLS models, it is not necessary to obtain data in the temperature range covering the frequency upturn below 100 mK seen in the TLS fit curve in Fig. 2.

The thermal desaturation of TLS below 1 K results in absorption of microwave photons, leading to a power- and temperature-dependent resonator loss rate [2,3]. At low microwave drive, the unsaturated TLSs dominate the loss,

but as the microwave drive increases, these TLSs become saturated, and, therefore, their loss rate decreases. At high microwave drives, where the TLSs are saturated, the loss becomes dominated by residual quasiparticles, with a loss rate δ_{QP} which is temperature dependent but assumed to be independent of microwave power [19]. The TLS and quasiparticle loss behavior can be described by

$$\frac{1}{Q_i} = \delta_{\text{tot}}^i = F\delta_{\text{TLS}}^0 \frac{\tanh\left(\frac{\hbar\nu_0}{2k_B T}\right)}{\left[1 + \left(\frac{\langle n \rangle}{n_c}\right)\right]^\beta} + \delta_{\text{QP}}, \quad (3)$$

where n_c is the number of photons equivalent to the saturation field of the TLS, β describes how quickly the TLSs saturate with power, and $F\delta_{\text{TLS}}^0$ is the TLS-loss tangent ($F\delta_{\text{TLS}}^0$ is power and temperature independent). TLS models were originally based on the anomalous properties of glasses at low temperatures [6] and assumed noninteracting TLSs, which leads to a prediction of $\beta = 0.5$. However, as superconducting circuits have improved, this model has failed to accurately describe the power dependence of dielectric losses: a weaker power dependence with $\beta < 0.5$ is frequently found [3,26–28]. This shows the need to consider TLS interactions [4,5,7,26,29], changing the loss model to [7,29]

$$\frac{1}{Q_i} = F P_\gamma \chi \ln\left(\frac{C n_c}{n} + \delta'_{\text{QP}}\right) \tanh\left(\frac{\hbar\nu_0}{2k_B T}\right), \quad (4)$$

where χ is the dimensionless TLS parameter, P_γ is the TLS switching rate ratio, C is a large constant, and δ'_{QP} is the log-scaled quasiparticle loss rate.

This loss is examined in more detail by fitting the resonator S_{21} response as a function of microwave drive and temperature [shown in Figs. 3(a)–3(c)]. Figure 3(a) [Fig. 3(c)] shows measurements of δ_{tot}^i (where $\delta_{\text{tot}}^i = 1/Q_i$) as a function of $\langle n \rangle$ on bare (nanowire-embedded) resonators. Each resonator has its own symbol, with solid (hollow) symbols corresponding to measurements in a normal (ECCOSORB-lined) sample box. ECCOSORB CR-117 (see the Supplemental Material [30]) is a microwave absorber which has been shown to reduce quasiparticle excitation from stray infrared (IR) photons [40]. The ECCOSORB lining is shown in Fig. 1(e). Different colors correspond to different temperatures. When analyzing Figs. 3(a) and 3(c) with Eq. (3), we find $\beta \approx 0.1$ – 0.2 (see the Supplemental Material [30]) implying interacting TLSs. The solid lines represent fits to the interacting-TLS model, Eq. (4). Table I collects fit parameters from both models.

We first consider bare resonators measured in a standard sample box [solid symbols in Fig. 3(b)]. The resonators on the same chip show a fabrication-based variability also found in the literature [2,19,41]: high- $\langle n \rangle$ $Q_i = (1.2\text{--}3.1) \times 10^6$ and low- $\langle n \rangle$ $Q_i = (3.6\text{--}5.7) \times 10^5$ at 307 mK. Increasing

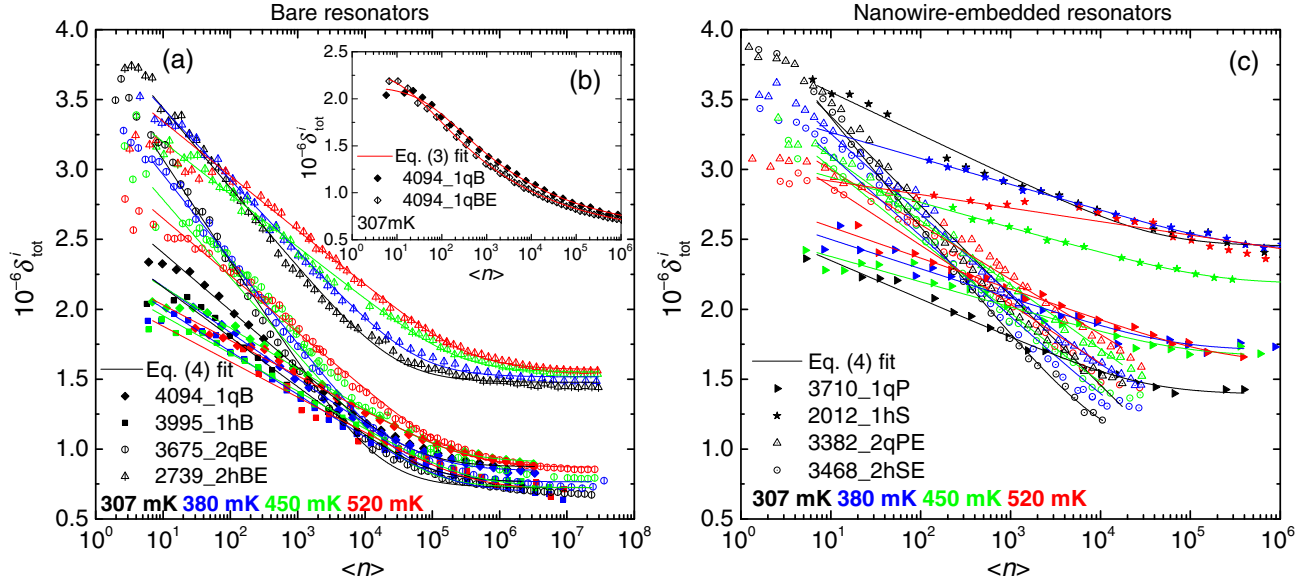


FIG. 3. (a) Loss tangent ($\delta_{\text{tot}}^i = 1/Q_i$) as a function of microwave drive for bare resonators. The colors correspond to different temperatures, and the hollow symbols indicate the use of an ECCOSORB-CR-117-lined sample box. The solid lines in all plots represent fits to Eq. (4). (b) Loss tangent for the resonator 4094_1qB with and without the ECCOSORB-lined box. (c) Loss tangent as a function of microwave drive for the nanowire-embedded resonators.

the temperature leads to an increase in low- $\langle n \rangle$ Q_i because, as thermal occupation of the TLSs increases, their ability to absorb microwave photons decreases [3,41], as described by the tanh temperature term. Increasing temperature also leads to a decrease in high- $\langle n \rangle$ Q_i . This is due to a higher quasiparticle density, meaning that more energy is lost to the quasiparticle system [19].

We next consider nanowire-embedded resonators in the standard sample box [solid symbols in Fig. 3(c)]. At 307 mK, at low $\langle n \rangle$, we find $Q_i = (2.7\text{--}3.9) \times 10^5$, in good agreement with the results from the bare resonators, so the FIB-based fabrication of the nanowire has produced very little additional TLS loss. At high $\langle n \rangle$, we find $Q_i = (4.1\text{--}7.2) \times 10^5$, 3–5 times lower than the bare resonators, indicating a higher residual quasiparticle density for the nanowire-embedded resonators.

Quasiparticles generated from pair-breaking events are an important consideration in conventional Josephson-junction devices [42], where ECCOSORB is typically used to reduce quasiparticle-based losses caused by stray IR photons [40,42]. We examine whether quasiparticles generated from IR photons are important for nanowire-embedded resonators by measuring them in an ECCOSORB-lined sample box. As the hollow dotted symbols in Fig. 3(c) show, losses at high $\langle n \rangle$ are much lower than for the standard sample box and $Q_i \approx (6\text{--}9) \times 10^5$. This value matches that of the bare resonators for the same $\langle n \rangle$, suggesting that the density of residual quasiparticles is reduced to that of the bare resonators (see Table I). A saturated high- $\langle n \rangle$ Q_i is not observed, due to nonlinearities in the resonance line shape of the nanowire-embedded resonators. With the smaller

quasiparticle-based loss, the TLS-based low- $\langle n \rangle$ trend of loss increasing as $\langle n \rangle$ decreases is once again found. The high- $\langle n \rangle$ Q_i is found to increase with increasing temperature, consistent with losses from thermally generated quasiparticles as found in the bare resonators, indicating that increased quasiparticle losses in nanowire-embedded resonators in the normal sample box arise from quasiparticles excited by IR photons. As Table I shows, δ_{QP} of the nanowire-embedded resonators in the ECCOSORB environment match those of the bare resonators (both with and without the ECCOSORB environment) and are, therefore, limited by another mechanism which is not unique to the nanowire.

Figure 3(b) shows the loss for the same bare resonator with and without the ECCOSORB enclosure. In contrast to nanowire-embedded resonators, the high- $\langle n \rangle$ loss decreases only slightly when the ECCOSORB-lined sample box is used. This is actually unsurprising since the energy gap of NbN is approximately 10 times larger than in Al. On the other hand, the reason for the sensitivity to IR photons in the nanowire-embedded resonators is not immediately obvious. Our results demonstrate the importance of IR filtering even when nanowires have a large superconducting energy gap such as those in NbN. This finding is relevant to all nanowire-based devices. We note that a small suppression of T_c in our nanowire (below the precision of our T_c determination) can give some enhanced sensitivity to IR photons. Alternative explanations for the sensitivity include the nanowire exhibiting a different quasiparticle lifetime [43] or nonequilibrium superconductivity [44], but these are beyond the scope of this study, although, since Q_i

remains high, the number of quasiparticles created from IR photons must still be quite small [40].

Finally, we compare the consistency of the TLS-loss rates (Table I and Supplemental Material [30]) obtained from the analysis of the data shown in Figs. 2 and 3. $F\delta_{\text{TLS}}^i$ and $F\delta_{\text{TLS}}^0$ differ by less than 20%; this difference is because $F\delta_{\text{TLS}}^0$ is sensitive only to near-resonant TLSs, whereas $F\delta_{\text{TLS}}^i$ is also sensitive to a broad spectrum of off-resonant TLSs [3,41,45]. Next, we note that $\delta_{\text{TLS}}^i = \chi$ [7] so that the ratio $FP_\gamma\chi/F\delta_{\text{TLS}}^i$ gives P_γ . We find an average value of $P_\gamma = 0.093$. This agrees well (see the Supplemental Material [30]) with the charge noise spectra of single-electron transistors that give $P_\gamma \approx 0.10$ [46,47]. Therefore, all TLS-loss rates are consistent with each other. The TLS-loss rates imply a TLS-limited Q_i up to approximately 2×10^5 in the quantum limit (at temperatures down to 10 mK and at single-photon energies). This value is approximately 100× larger than in equivalent nanowire-embedded resonators and compares favorably with Josephson-junction-embedded resonators.

IV. CONCLUSION

To conclude, we use a neon FIB to create superconducting nanowires with widths down to 20 nm within superconducting resonators. In the low-power limit, these devices demonstrate Q_i up to 3.9×10^5 at 300 mK, with δ_{TLS}^i and δ_{TLS}^0 corresponding to a TLS-limited Q_i up to 2×10^5 at 10 mK. These TLS losses arise from the NbN thin-film technology rather than the neon FIB, meaning a higher Q_i should be possible with better resonator technology [41]. By obtaining such a high Q_i using nanowires, we demonstrate a critical step towards realizing nanowire-based, superinductance, phase-slip or Dayem-bridge circuits with coherence times comparable to conventional Josephson-junction-type devices.

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